

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination 09/972,229 WEE ET AL.	
		Examiner	Art Unit	Page 2 of 2 Eleni A. Shiferaw 2136

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,914,751 A	06-1999	Korth, Hans-Erdmann	375/240.12
*	B	US-6,553,072 B1	04-2003	Chiang et al.	375/240.25
*	C	US-6,580,754 B1	06-2003	Wan et al.	375/240.01
*	D	US-6,782,550 B1	08-2004	Cao, Yousheng	725/39
*	E	US-6,931,534 B1	08-2005	Jandel et al.	713/176
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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